

## **MAIL STOP AF** RESPONSE UNDER 37 C.F.R. § 1.116 EXPEDITED PROCEDURE **EXAMINING GROUP 2800**

# THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants:

R.B. Darling et al.

Attorney Docket No.: UWOTL121266

Application No.: 10/611,327

Art Unit: 2881 / Confirmation No.: 3726

Filed:

June 30, 2003

Examiner: B.E. Souw

Title:

CHARGED PARTICLE BEAM DETECTION SYSTEM

TRANSMITTAL LETTER FOR RESPONSE AFTER FINAL REJECTION UNDER 37 C.F.R. § 1.116

December 5, 2005

### TO THE COMMISSIONER FOR PATENTS:

#### A. Response Transmittal

Transmitted herewith is a response to an Office Action in the above-identified application. No additional claim fee is required.

#### B. Additional Fee Charges or Credit for Overpayment

The Commissioner is hereby authorized to charge any fees under 37 C.F.R. §§ 1.16, 1.17 and 1.18 which may be required during the entire pendency of the application, or credit any overpayment, to Deposit Account No. 03-1740. This authorization also hereby includes a request for any extensions of time of the appropriate length required upon the filing of any reply during the entire prosecution of this application.

Respectfully submitted,

CHRISTENSEN O'CONNOR JOHNSON KINDNESSPLLC

George P. Renzoni, Ph.D. Registration No. 37,919

Direct Dia No. 206.695.1755

I hereby certify that this correspondence is being deposited with the U.S. Post Service In a sealed envelope aprirst class mail with postage thereon fully prepaid and addressed to Mail Staff Complissioner for Patents, P. Box 1450, Alexandria, VA 22313-1450, on the below date

Date:

GER:md

LAW OFFICES OF

CHRISTENSEN O'CONNOR JOHNSON KINDNESSITAL

1420 Fifth Avenue **Suite 2800** Seattle, Washington 98101 206.682.8100

UWOTL\21266148A.DOC



## **MAIL STOP AF** RESPONSE UNDER 37 C.F.R. § 1.116 **EXPEDITED PROCEDURE EXAMINING GROUP 2800**

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants:

R.B. Darling et al.

Attorney Docket No.: UWOTL121266

Application No.: 10/611,327

Art Unit: 2881 / Confirmation No.: 3726

Filed:

June 30, 2003

Examiner: B.E. Souw

Title:

CHARGED PARTICLE BEAM DETECTION SYSTEM

### **RESPONSE TO FINAL REJECTION**

Seattle, Washington 98101

December 5, 2005

### TO THE COMMISSIONER FOR PATENTS:

In response to the Examiner's Action mailed October 4, 2005, please enter the following remarks.